Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/510,241	JANG, YOU-SEOK
Examiner	**Art Unit**
Tan Le	3632

SEARCHED			
Class	Subclass	Date	Examiner
248	118	3/17/06	TL
	118.1		
	118.3		
	917		
	918		
	919		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East Text Search IPC Search	3/17/06	TL